

PATENT  
Attorney Docket No. 210091

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Hinken et al.

Art Unit: Unassigned

Application No. Unassigned  
(U.S. National Phase of PCT/EP99/07440)

Examiner: Unassigned

Filed: April 4, 2001

For: TESTING DEVICE FOR DETECTING  
AND LOCALIZING MATERIAL  
INHOMOGENEITIES

PRELIMINARY AMENDMENT

Commissioner for Patents  
Washington, D.C. 20231

Dear Sir:

Prior to the examination of the above-identified patent application, please enter the following amendments and consider the following remarks.

IN THE CLAIMS:

Please cancel claims 1-11.

Please add the following new claims:

12. A testing device for detecting and localising material inhomogeneities in electrically conductive samples comprising a holder for the sample to be tested, a temperature setting device for forming a temperature profile in the sample, and at least one measuring sensor for the contactless measurement of the magnetic field outside the sample, wherein several measuring sensors are provided at a different distance to the sample.

13. The testing device of claim 12, wherein the holder is connected to a rotational drive for rotating the sample.

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Amend  
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D.JS

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